



# **inEMI**

International Electronics Manufacturing Initiative

## **Lead-Free Rework Optimization Project**

*Project Chair: Jasbir Bath  
Solectron Corporation*

*Project Co-Chair: Craig  
Hamilton,  
Celestica*

*IPC APEX 2007  
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**Advancing manufacturing technology**

# Background

- **Reliability tests in the previous NEMI lead-free assembly and rework project (presented at APEX) indicated a need to initiate a follow on iNEMI Rework Optimization Project.**
- **Thermal fatigue life of certain components on the NEMI Payette board such as the CBGA937, uBGA256, CSP81 was reduced after rework.**
- **This project would evaluate and recommend best practices, rework equipment requirements, impact of adjacent component temperatures and procedures for best practice lead-free rework processing.**

# **Rework optimization project** **(4 areas of work)**

- 1) Rework tolerances and repeatability (Rework equipment manufacturers)**
- 2) Optimized heat transfer into reworked boards and work to reduce adjacent (Top and Bottom) component temperatures: use of heat shrouds, more uniform board heating, heat shields**
- 3) BGA Socket and FCBGA component rework**
- 4) Lead-free mini-pot wave connector rework**

# iNEMI Rework Optimization Project Participants

## Members

- Solectron, Jabil, Celestica, Sanmina-SCI, Plexus, Foxconn, LACE Technologies
- Cisco, Alcatel-Lucent, SUN, HP
- TI, Tyco, Intel, IBM
- Indium, Kester, Senju
- O.K. Industries, ERSA

## **Non-members participating in certain parts of project**

- SRT/VJ Technologies
- AirVac
- Finetech
- ECD
- Spencor Technic

## Rework optimization project

Overall project chairs: Jasbir Bath, Solectron / Craig Hamilton, Celestica

**1) Rework tolerances and repeatability**

**Chair:** Jasbir Bath, Solectron

**2) Optimized heat transfer into reworked boards and work to reduce adjacent component temperatures**

**Chair:** George Forrest/ Joe Devaney, Alcatel-Lucent

**3) BGA Socket and FCBGA package rework**

**Chair:** Alan Donaldson, Intel

**4) Lead-free mini-pot connector rework**

**Chair:** Jenny Porter, Solectron

**Co-Chair:** Denis Jean, Plexus

**5) Rework Reliability Testing/ Failure Analysis**

**Chair:** Dave Love, SUN



# 1) BGA//CSP Rework Machine Repeatability and Tolerance Study Background

Currently we have little or no data on temperature repeatability of BGA/CSP rework equipment.

This is an issue for lead-free as the temperatures during lead-free BGA/CSP rework are likely to be higher than lead-free reflow soldering giving potential component/board temperature issues.

# 1) BGA/CSP Rework machine repeatability and Tolerance Temperature Study

## (Fixed Temperature Input: Measure Temperature Output)

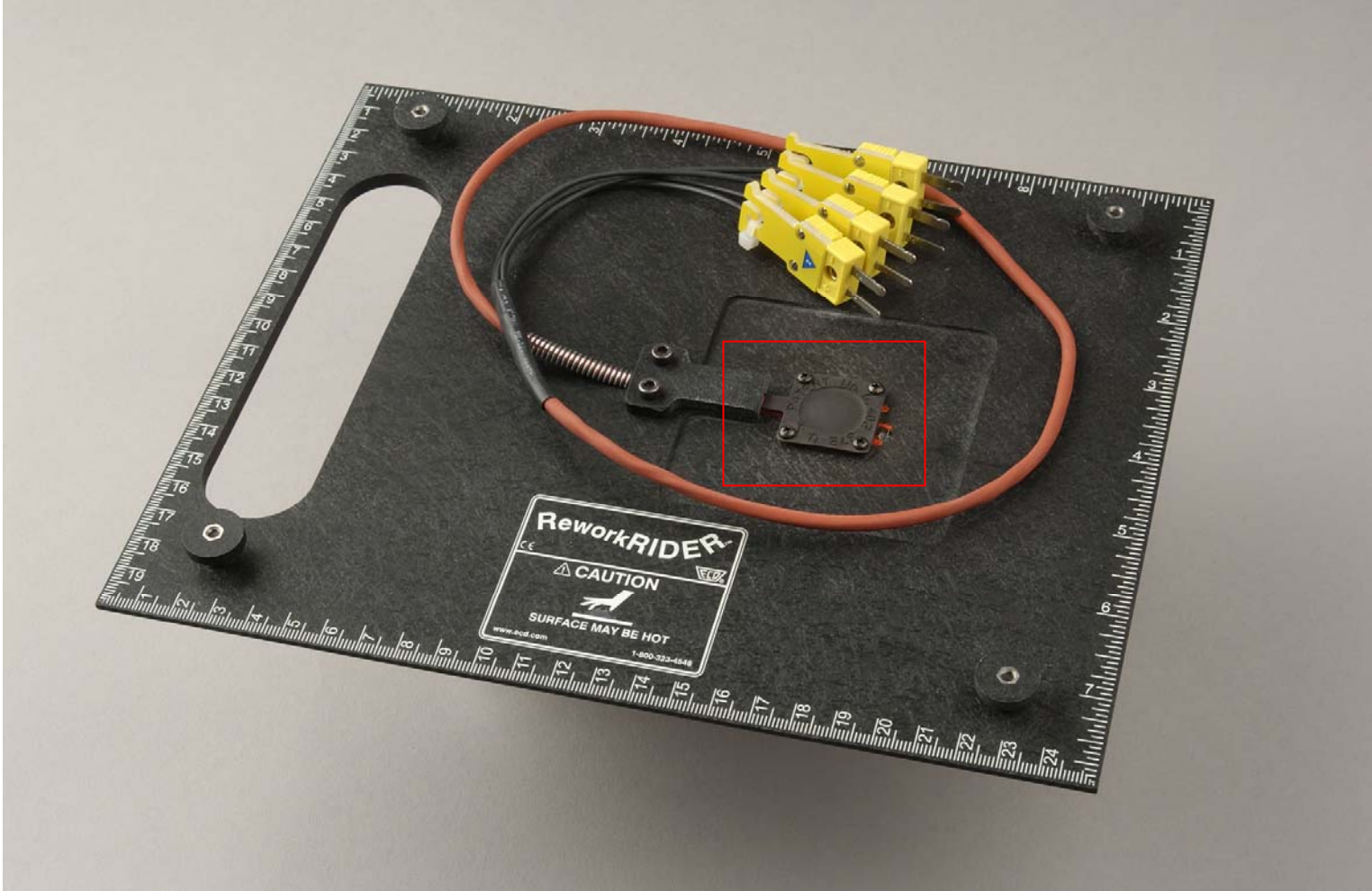
**Stage 1: Rework manufacturer to use ECD rework rider to record temperatures using defined lead-free rework temperature set-points and rework time durations with a specific rework machine**

**Stage 2: Same test at rework manufacturer with ECD rework rider with same machine model but with different rework machine, using same rework temperature set-points and time durations as Stage 1**

**Stage 3: Same test conducted at OEM/ EMS site with ECD rework rider with rework equipment at site, using same rework temperature set-points and time durations as Stages 2 and 3**

**Compare data from each three stages to determine and improve rework machine temperature repeatability and tolerances**

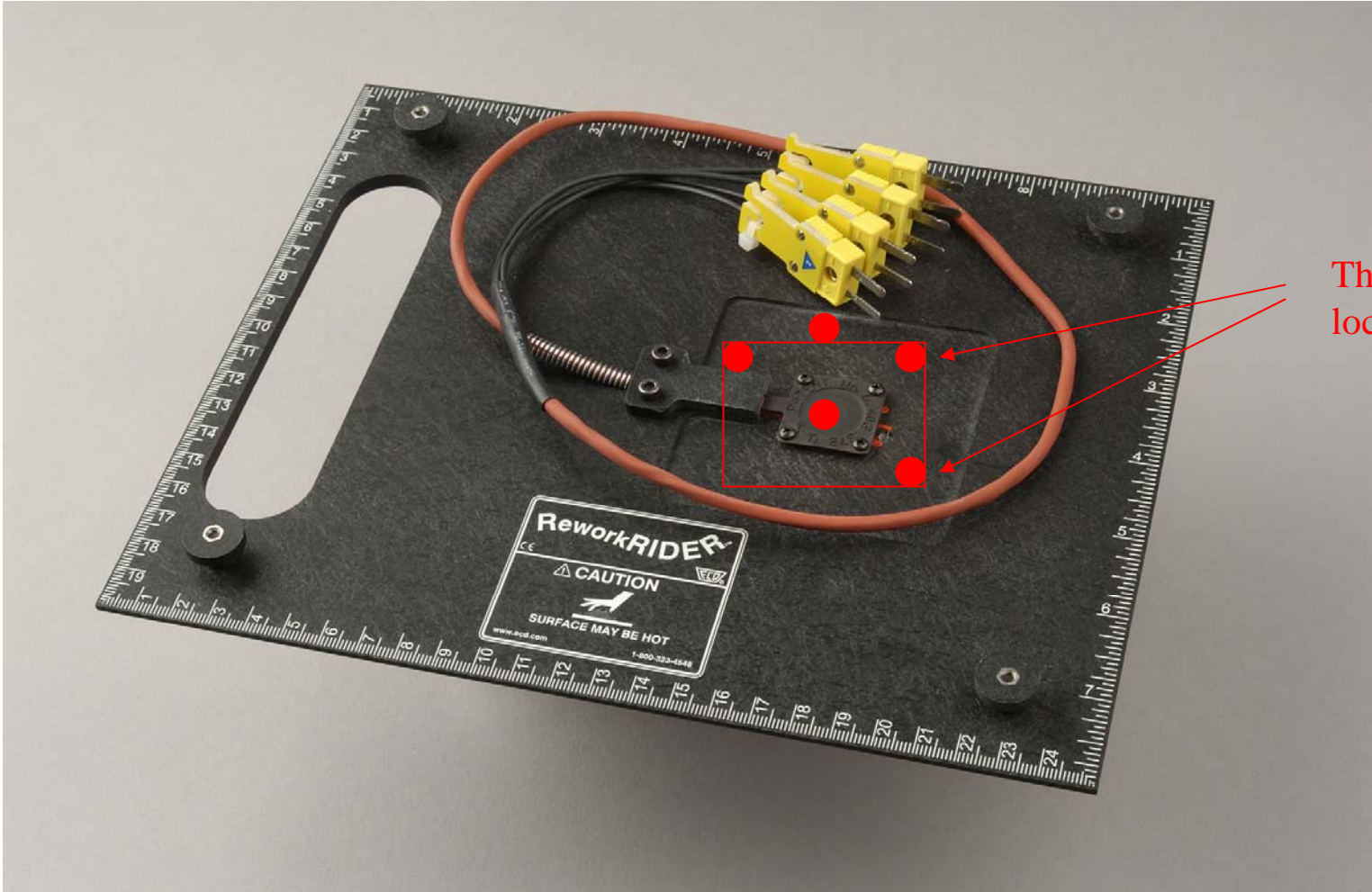
# ECD ReworkRIDER™ (Records temperatures from a BGA/CSP rework machine)



# Rework Rider Retrofits

- 1. Two thermocouples at corners of imaginary 35mm package on topside (Locations on North-West and South-East corners)
- 2. One thermocouple location on the bottomside of the board on the corner of an imaginary 35mm package (North-East corner)
- 3. Two thermocouples at the center of an imaginary package (1 topside center and 1 bottomside of the board in the center)
- 4. One thermocouple at 150mils away from component in the North direction on topside of the board
- Total: 6 Thermocouple locations on the Rework Rider

# ECD ReworkRIDER™ Thermocouple locations



Thermocouple locations



# BGA Rework Profile Development

- Use a lead-free rework profile (230°C to 260°C peak soldering temperature[Time above Liquidous: 45 to 100sec]) developed on the 135mil NEMI Payette board for a lead-free PBGA544 component (35mmx35mm) and use this profile on the rework rider.
- Use this profile to understand and measure temperature repeatability of the BGA/CSP rework equipment using rework rider
- Run the same lead-free rework profile on the rework machine 10 times and measure the temperature peaks recorded at the 6 different temperature locations on the rework rider which is placed in the rework machine.
- Ensure after each of the 10 runs the rework rider temperature is cooled down to room temperature

# Rework Machine Supplier A Temperature Results

## Single Rework Machine Temperature Repeatability Results(with 99% Confidence Level in Repeatability of Temperature Measurements)

- TC1 Top Center Average Peak Temperature = 274°C +/- 4°C
  - TC2 Top North West Component Corner = 309°C +/- 6°C
  - TC3 150mils away from Component on Topside = 264°C +/- 5°C
  - TC4 North East Corner on Bottomside = 318°C +/- 5°C
  - TC5 Top South East Component Corner = 279°C +/- 5°C
  - TC6 Bottomside Center = 272°C +/- 5°C
- 99% of the all readings are within +/-5°C around the recorded peak temperature at each thermocouple location
  - For example: If the recorded lead-free top component body peak temperature reading on a board was actually 250°C, 99% of the time, the actual reading could be 5°C lower (245°C) or 5°C higher (255°C) than this value based on the temperature repeatability of this single rework machine

# Rework Machine Supplier A Temperature Results

- |   | Typical | Worst Case |
|---|---------|------------|
| • Machine Repeatability(Supplier site/Stage 1): | +/- 5°C | TBD        |
| • Machine/Machine Repeatability(Supplier site): | Stage 2 | TBD        |
| • Machine/Machine Repeatability(at EMS/OEM):    | Stage 3 | TBD        |
| • Thermocouple Repeatability:                   | +/- 1°C | +/- 2°C    |

This work will also be conducted on 3 other rework machine supplier's equipment (Rework Machine Suppliers B,C and D)

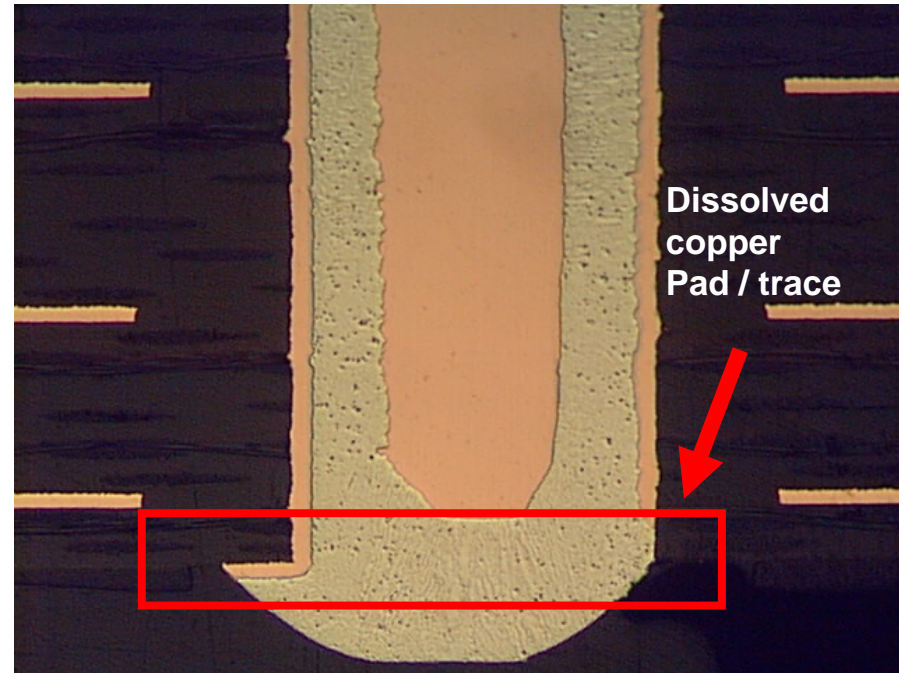
## **(4) Lead-free mini-pot connector rework development and optimization**

**Previous work covered only DIP16 on NEMI Payette. Extension to other connector components (DIMM, Centronics connector).**

**Collaboration work with NEMI lead-free wave project group using Phase 1 NEMI wave board**

# Previous iNEMI Mini-Pot Payette Board Results Showing PCB Copper Dissolution of Reworked PDIP16 Solder Joint (SnAgCu, NiAu board, 135 mil thick)

- **Challenge**
  - Simulate current production process
  - Remove and replace a PDIP without board preheat
- **Rework Observations**
  - Achieving sufficient holefill resulted in the copper pad/trace dissolution on the bottom-side



**Cross-section View of Solder Joint (274°C)**

Total time in mini-pot= 60sec

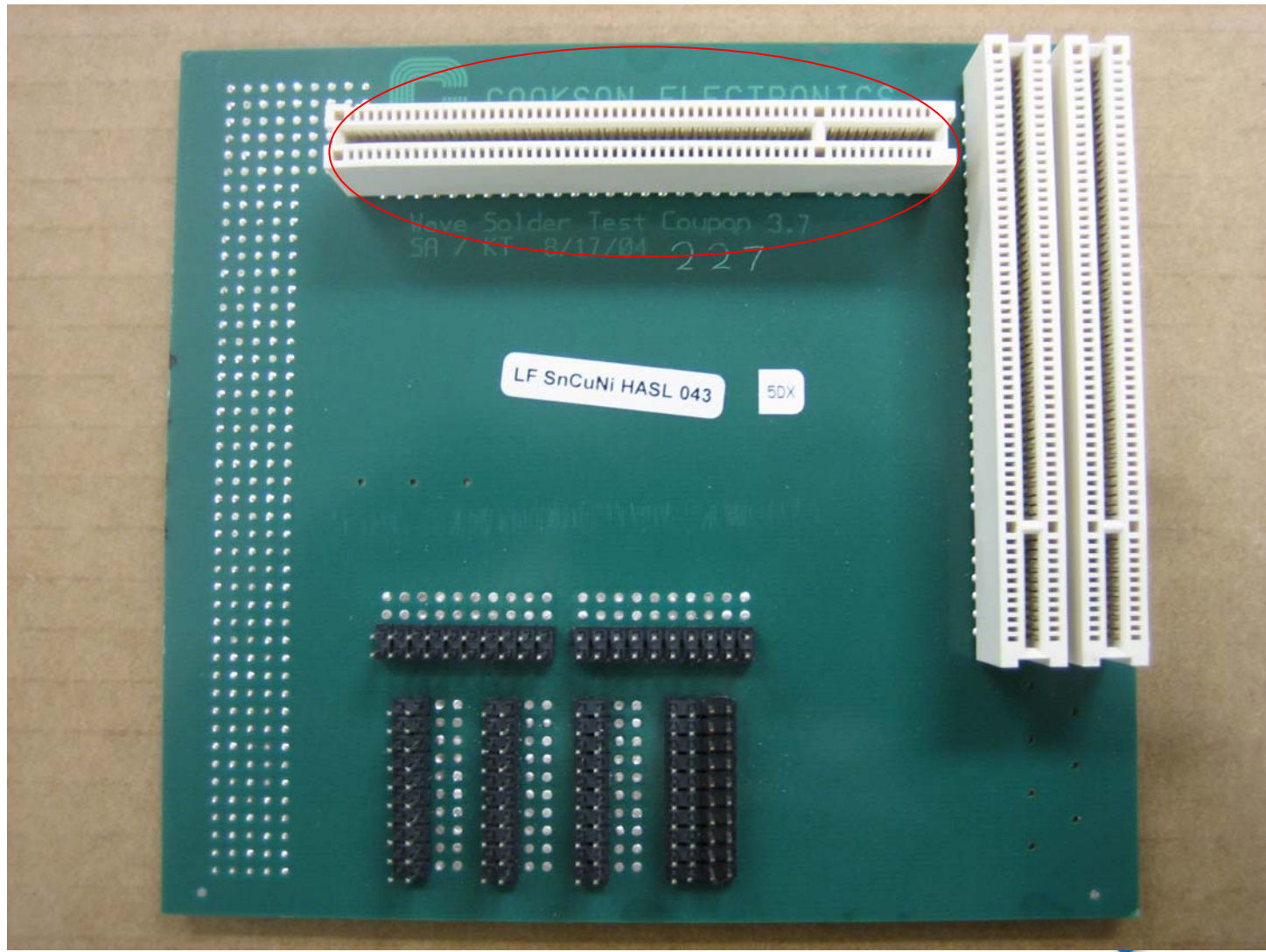
Enough time to dissolve nickel layer



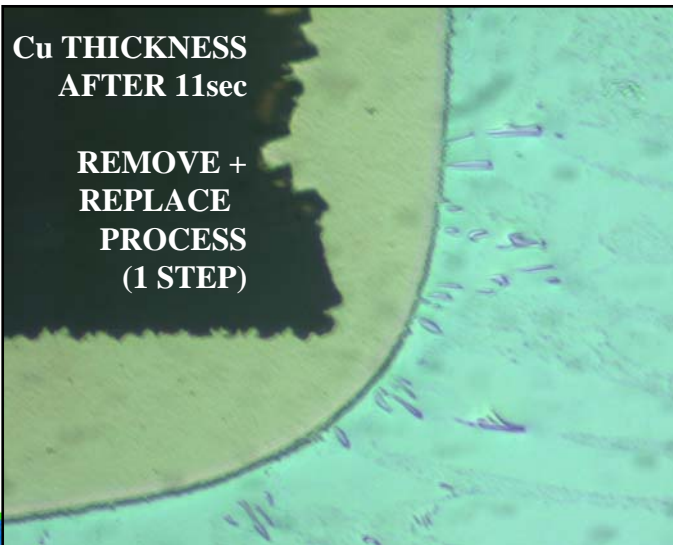
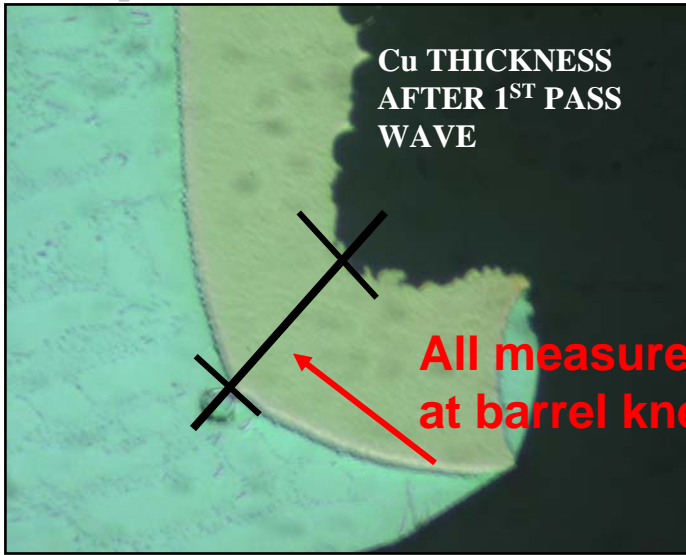
# NEMI Mini-pot rework

- Initial work of group is concentrating on rework of a wave soldered connector on 62mil, 93mil and 140mil thick NEMI Lead-free Wave Group Boards wave soldered with Sn3Ag0.5Cu
- Mini-pot solder rework alloys under investigation include Sn3Ag0.5Cu and SnCuNi (Sn100C)

# NEMI Wave Phase 1 Test Vehicle



# SnAgCu 1<sup>st</sup> pass wave followed by SnAgCu mini-pot rework on 60mil thick NEMI Wave board



# 60 mil thick NEMI board (SnAgCu 1<sup>st</sup> pass wave then SnAgCu rework)

60 MILS THK BOARD	PIN1		PIN2		PIN3		PIN4		PIN5		PIN6		PIN7		PIN8		AVG
	L	Ri	L	Ri	L	Ri	L	Ri	L	Ri	L	Ri	L	Ri	L	Ri	
LF-SAC305 OSP# 19- 1 <sup>ST</sup> PASS WAVE	46	38	47	38	46	38	49	41	50	39	47	39	50	40	52	38	43.6
LF-SAC305 OSP# 043- 11SEC (1STEP)	32	36	28	36	28	33	28	32	19	30	21	34	16	30	26	33	28.9
LF-SAC305 OSP# 001- REMOVE + DRESS	28	38	34	30	36	32	31	32	35	36	34	33	33	38	40	38	34.3
LF-SAC305 OSP# 052- REMOVE + DRESS + REPLACE (3STEP)	25	30	24	28	26	30	23	26	24	30	24	22	26	28	28	28	26.4

**1<sup>ST</sup> PASS WAVE BOARD 43.6microns**

**BRD # 001- Remove + Site Dress 34.3 microns 21.3% DECREASE IN Cu THK**

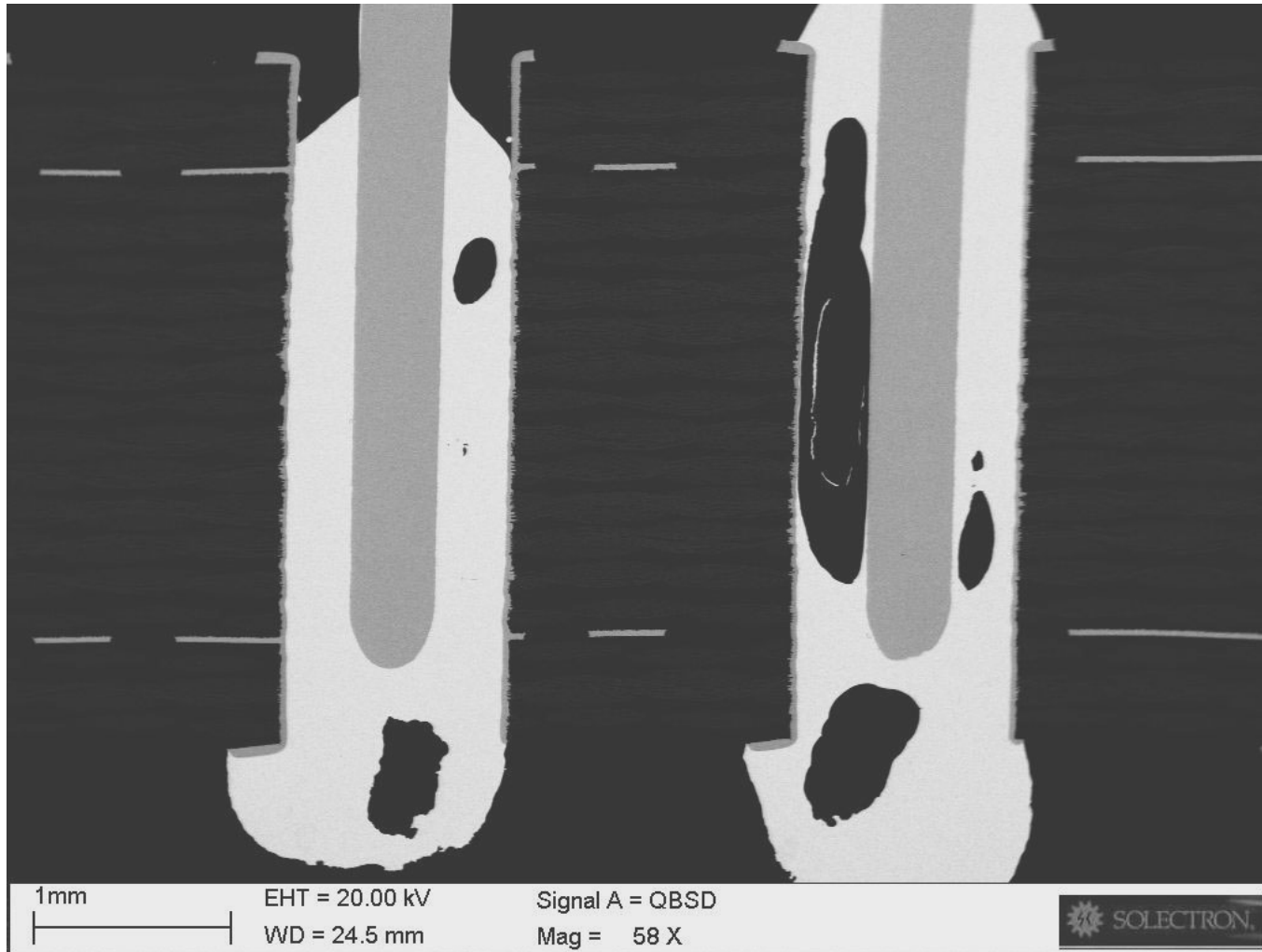
**BRD # 052- Remove + Site Dress+ Replace 26.4 microns 39.5% DECREASE IN Cu THK**  
**BRD # 043- 11sec Remove + Replace (1 step process) 28.9 microns 34% DECREASE IN Cu THK**

**ALL MEASUREMENTS TAKEN AT THE BARREL KNEE (Measurement in Microns)**

*L-LEFT KNEE, Ri- RIGHT KNEE,*



# 145 mil thick board: 1<sup>st</sup> pass wave soldered with Sn3Ag0.5Cu then reworked with Sn3Ag0.5Cu



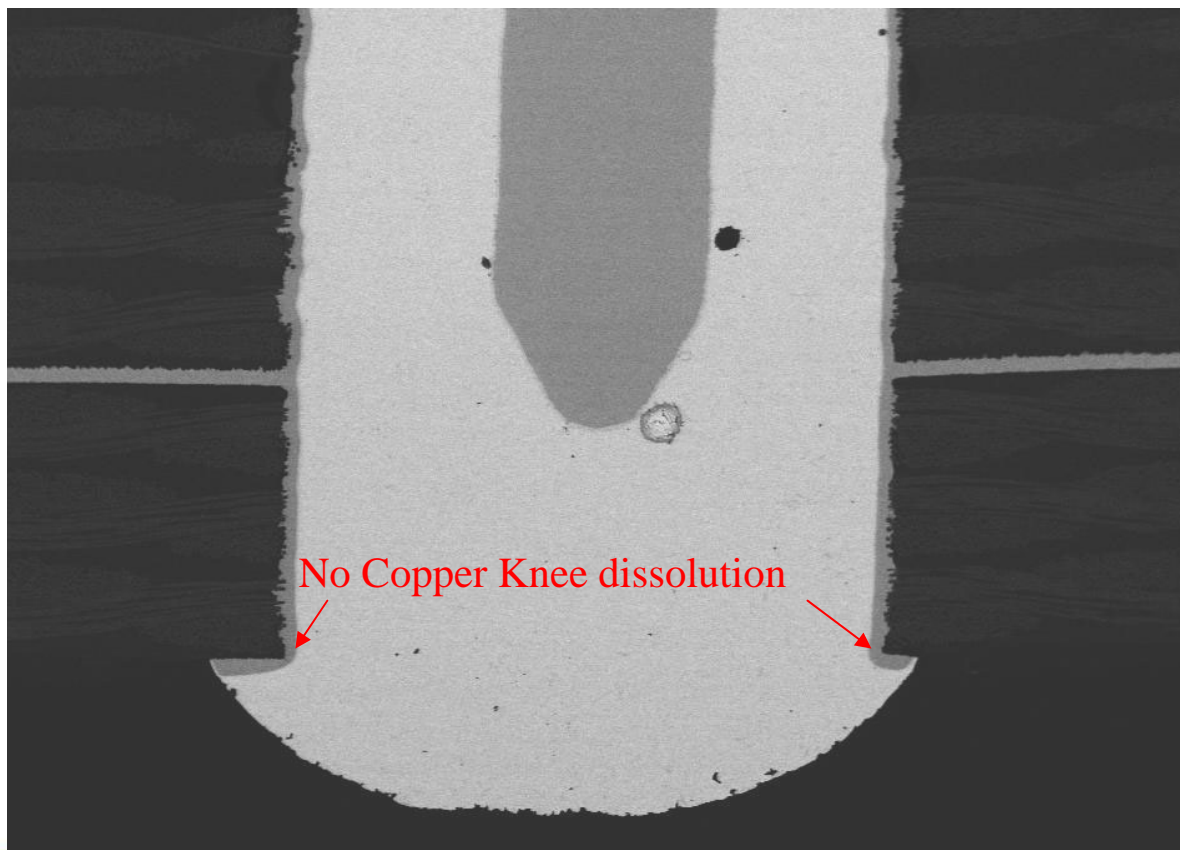
ALL MEASUREMENTS TAKEN AT THE BARREL KNEE  
AFTER REPLACEMENT

**INEMI**

# 145 mil thick board

## 1<sup>st</sup> pass wave soldered with Sn3Ag0.5Cu then reworked with SnCuNi (SN100C)

145 mils thick board	Pin 1		Pin 2		Pin 3		Pin 4		Avg. (microns)	Remove (sec)	Remove Replace (sec)
	left (microns)	right (microns)	left (microns)	right (microns)	left (microns)	right (microns)	left (microns)	right (microns)			
LF-SAC305 HASL #040	46	40	42	41	40	35	39	36	40	26	
LF-SAC305 HASL #028	21	22	23	30	14	26	14	26	22		38



Solder Alloy: SN100C  
Solder Temp: 276°C / 530°F  
Preheat: 150°C / 302°F  
Preheat Time: 300sec  
Rwk Flux: Tacky/ Pasty Flux

ALL MEASUREMENTS TAKEN AT THE BARREL KNEE



# Mini-pot Rework

- **Generally speaking there is evidence of reduced copper dissolution when reworking 1<sup>st</sup> pass SnAgCu wave soldered boards with SnCuNi(Sn100C) compared with rework using SnAgCu. More investigations and cross-sectional analysis in progress**
- **Further optimization and development work will be done on the NEMI Wave Phase 1 boards before moving to the iNEMI Payette Board which is 125mil thick (OSP coated)**
- **Mini-pot Rework on iNEMI Payette board will concentrate on the DIMM 278 connector and DIP16 component**

# NEMI Rework Optimization Project Status

- **At this time, most of the group's work has concentrated on Mini-Pot rework optimization and Rework Machine Temperature Repeatability**
- **Work on adjacent component temperatures during rework and FCBGA/ BGA socket/QFN rework will be done with the new 125mil thick iNEMI Payette test vehicle (7 x 17 inch) which has been redesigned and currently being tested for electrical continuity for the daisy chained components including:**
  - **FCBGA**
  - **BGA socket**
  - **DIMM 278**
  - **DIP16**
  - **CBGA**
  - **QFN**